GB02SLT12-214
1200V 2A SiC Schottky MPS™ Diode

GeneSiC SEMICONDUCTOR

Silicon Carbide Schottky Diode

V_{RRM}	=	1200 V
$I_{F\ (T_L \le 150°C)}$	=	2 A
Q_C	=	11 nC

Features

- Low V_F for High Temperature Operation
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Q_C/I_F
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness

Package

DO-214

RoHS

REACH

Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- High Voltage Sensing
- Solar Inverters
- Electric Vehicles
- High Frequency Converters
- Battery Chargers
- AC/DC Power Supplies
- Anti-Parallel / Free-Wheeling Diode
- LED and HID Lighting

Absolute Maximum Ratings (At T_L = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V_{RRM}		1200	V	
Continuous Forward Current	I_F	$T_L \le 150°C$	2	A	
Non-Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,SM}$	T_L = 25°C, t_P = 10 ms T_L = 150°C, t_P = 10 ms	20 16	A	
Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,RM}$	T_L = 25°C, t_P = 10 ms T_L = 150°C, t_P = 10 ms	12 9	A	
Non-Repetitive Peak Forward Surge Current	$I_{F,MAX}$	T_L = 25°C, t_P = 10 µs	100	A	
i^2t Value	$\int i^2dt$	T_L = 25°C, t_P = 10 ms	2	A^2s	
Non-Repetitive Avalanche Energy	E_{AS}	L = 18.0 mH, I_{AS} = 2 A	36	mJ	
Diode Ruggedness	dV/dt	V_R = 0 ~ 960 V	200	V/ns	
Power Dissipation	P_{TOT}	T_L = 25°C	84	W	Fig. 3
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C	

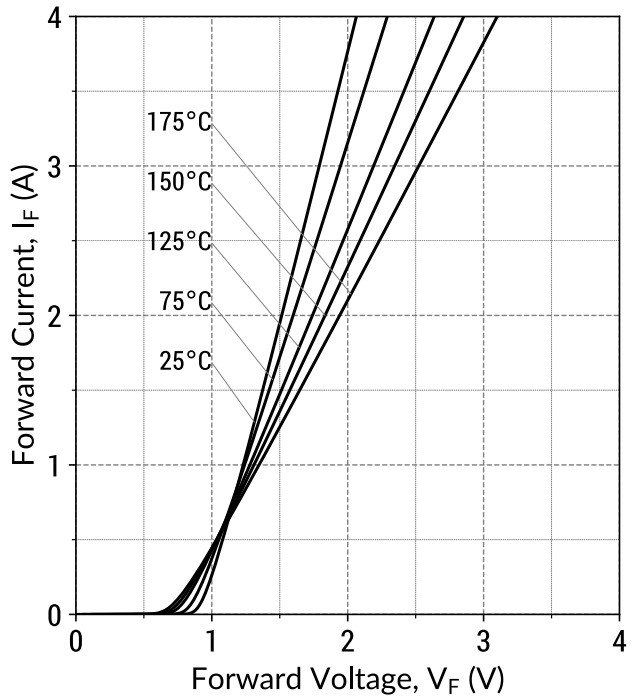
Electrical Characteristics

Parameter	Symbol	Conditions		Values			Unit	Note
				Min.	Typ.	Max.		
Diode Forward Voltage	V_F	I_F = 2 A, T_j = 25°C			1.5	1.8	V	Fig. 1
		I_F = 2 A, T_j = 175°C			1.9			
Reverse Current	I_R	V_R = 1200 V, T_j = 25°C			1	5	µA	Fig. 2
		V_R = 1200 V, T_j = 175°C			3			
Total Capacitive Charge	Q_C	$I_F \le I_{F,MAX}$ dI_F/dt = 200 A/µs	V_R = 400 V		7		nC	Fig. 5
			V_R = 800 V		11			
Switching Time	t_S		V_R = 400 V		< 10		ns	
			V_R = 800 V					
Total Capacitance	C	V_R = 1 V, f = 1MHz			122		pF	Fig. 4
		V_R = 800 V, f = 1MHz			7			

Thermal/Package Characteristics

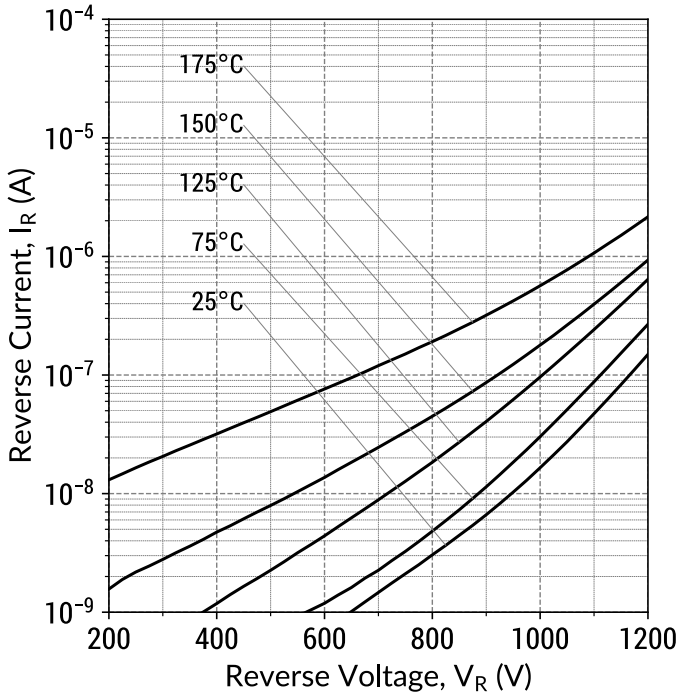
Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Thermal Resistance, Junction - Lead	R_{thJL}			5.17		°C/W	
Weight	W_T			0.3		g	

Figure 1: Typical Forward Characteristics



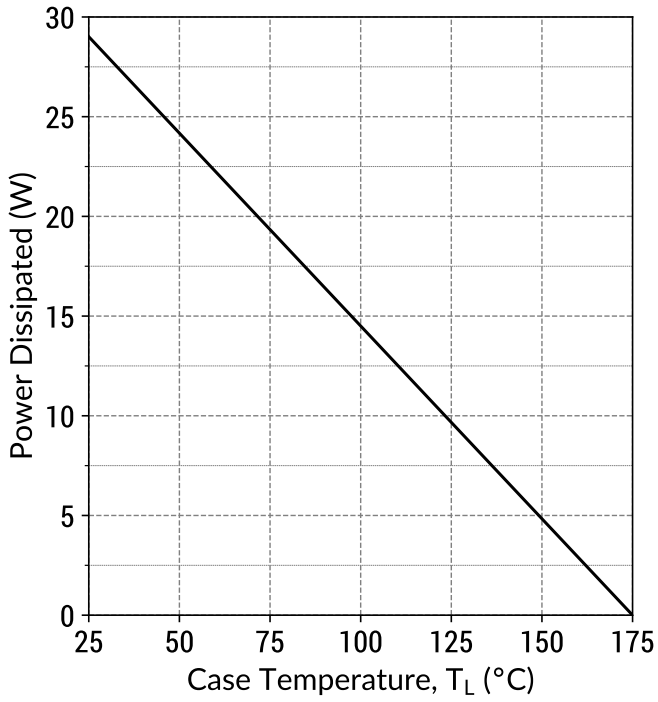
$I_F = f(V_F,T_j)$; t_P = 250 µs

Figure 2: Typical Reverse Characteristics



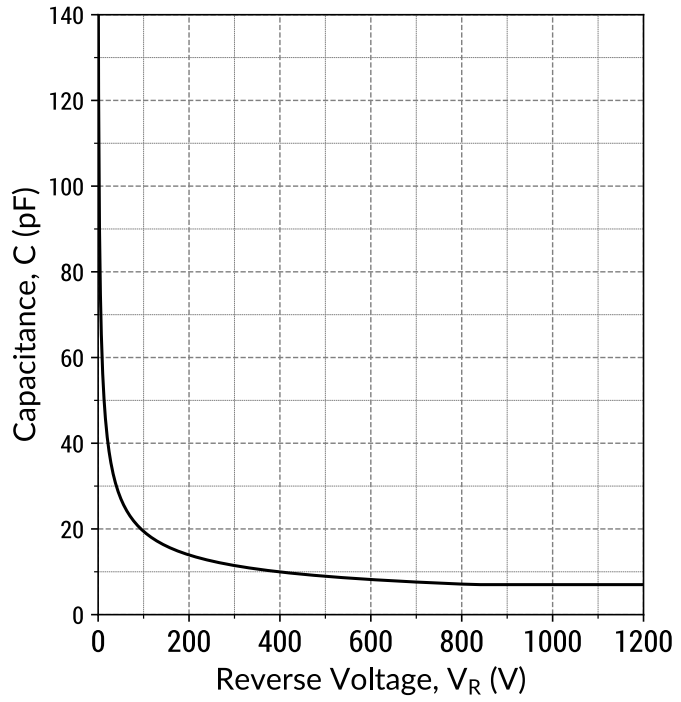
$I_R = f(V_R,T_j)$

Figure 3: Power Derating Curves



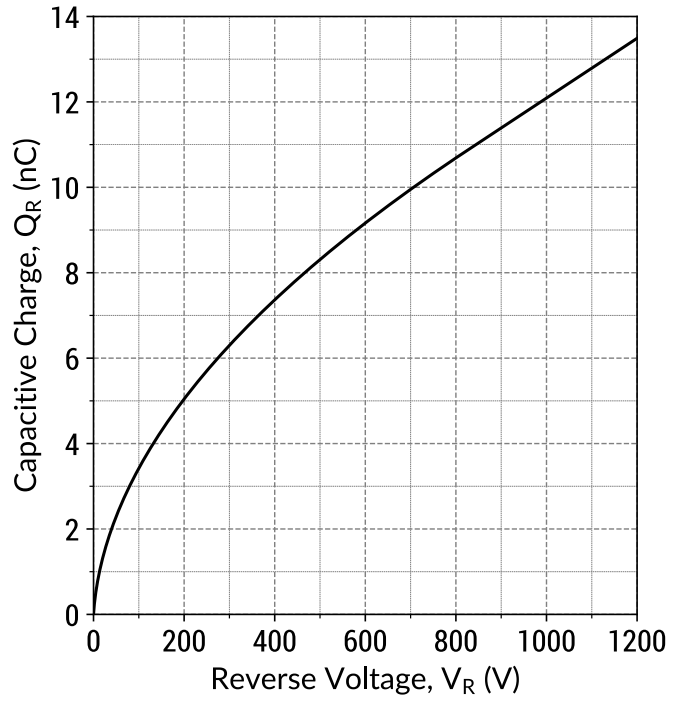
$P_{TOT} = f(T_L)$; T_j = 175°C

Figure 4: Typical Junction Capacitance vs Reverse Voltage Characteristics



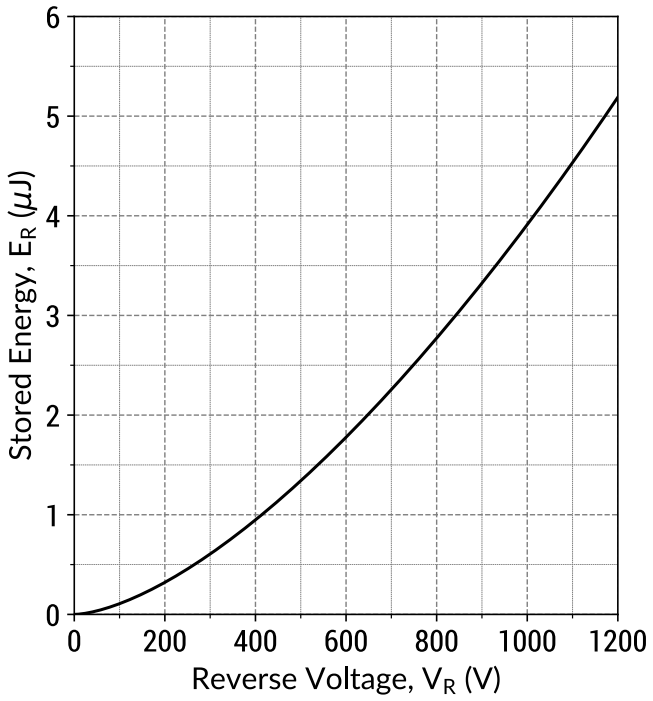
C = f(V_R); f = 1MHz

Figure 5: Typical Capacitive Charge vs Reverse Voltage Characteristics



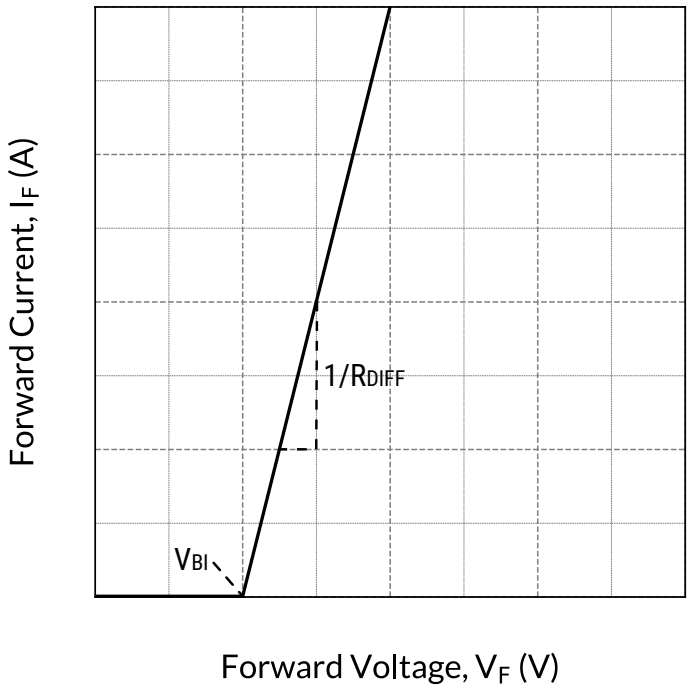
$Q_C = f(V_R)$; f = 1MHz

Figure 6: Typical Capacitive Energy vs Reverse Voltage Characteristics



$E_C = f(V_R)$; f = 1MHz

Figure 7: Forward Curve Model



$I_F = f(V_F, T_j)$

Forward Curve Model Equation:

$I_F = (V_F - V_{BI})/R_{DIFF}$ (A)

Built-In Voltage (V_{BI}):

$V_{BI}(T_j) = m \times T_j + n$ (V)

m = -0.00123 (V/°C)

n = 0.995 (V)

Differential Resistance (R_{DIFF}):

$R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c$ (Ω)

a = 5.96e-06 (Ω/°C^2)

b = 8.46e-04 (Ω/°C)

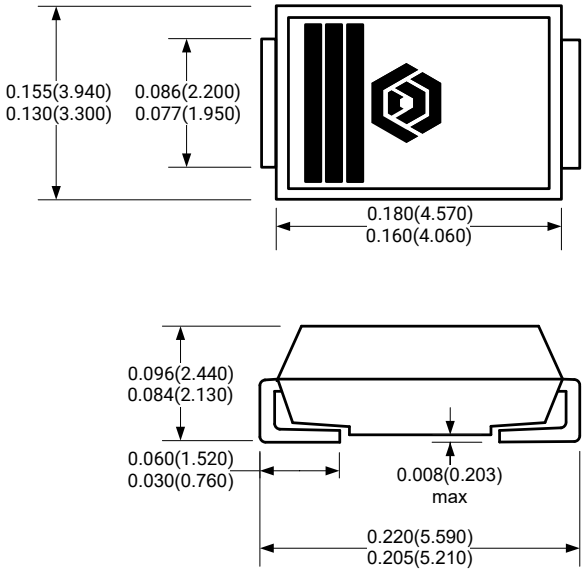
c = 0.251 (Ω)

Forward Power Loss Equation:

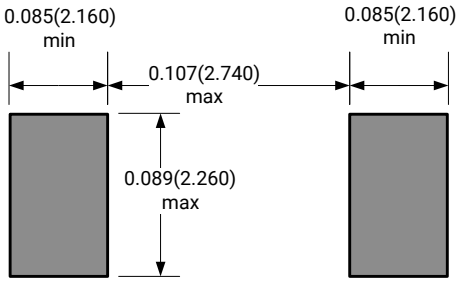
$P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$

Package Dimensions

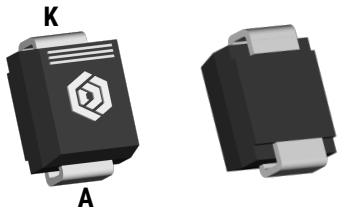
DO-214 Package Outline



Recommended Solder Pad Layout



Package View



NOTE

1. CONTROLLED DEIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control systems.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Related Links

- SPICE Models: https://www.genesicsemi.com/sic-schottky-mps/GB02SLT12-214/GB02SLT12-214_SPICE.zip
- PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GB02SLT12-214/GB02SLT12-214_PLECS.zip
- CAD Models: https://www.genesicsemi.com/sic-schottky-mps/GB02SLT12-214/GB02SLT12-214_3D.zip
- Evaluation Boards: https://www.genesicsemi.com/technical-support
- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

www.genesicsemi.com/sic-schottky-mps/

Published by GeneSiC Semiconductor, Inc.
43670 Trade Center Place Suite 155, Dulles, VA 20166; USA